



Wir schaffen Wissen – heute für morgen

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Thermal Design of Power Electronic Circuits
CERN Accelerator School 2014, Baden, Switzerland**

Motivation

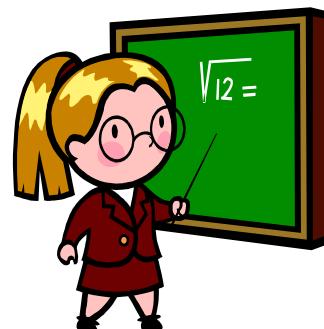


Statement in a meeting:

“The converter works as specified, there are just a couple of tests missing to check its thermal behavior.”

Statement in the follow-up meeting 2 weeks later:

“We could only test up to 50% of the rated power, otherwise the converter would have been burnt away.”

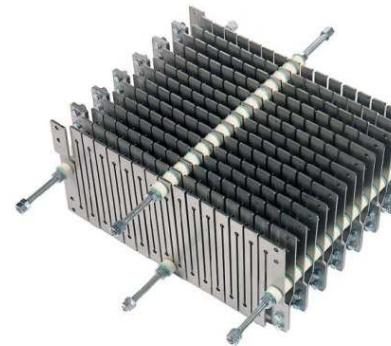


Lesson learnt:

Take the losses and the heat dissipation issues into account **from the very beginning!**

Heat Sources: Resistors

- Resistors
 - Continuous load
 - Sufficient heat transfer to ambient
 - Temperature \approx stable
 - Pulsed load
 - Absorb energy during pulses
→ sufficient active material
 - Temperature \neq stable
 - Limited repetition rate
- Cables
 - Use sufficient cross section → additional investment vs. loss costs
 - Skin effect
 - Skin depth in Cu @ 1kHz: 2.1mm
 - @ 10kHz: 0.7mm



Heat sources: Magnetic Components

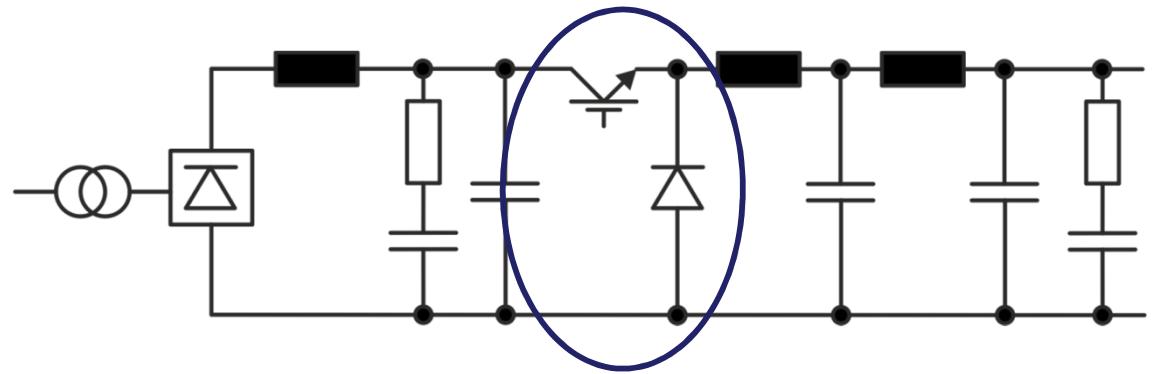
- Core losses
 - Eddy current losses
 - Iron sheet cores $f < 1\text{kHz}$
 - Powder cores $f < 10\text{kHz}$
 - Ferrite cores $f > 10\text{kHz}$
 - Hysteresis losses
 - Proportional to the area of the hysteresis curve and the frequency
 - Core losses in transformers
 - Designed to have a minimized hysteresis curve area
 - Losses increase with frequency
 - Losses are also present at zero load
 - DC-chokes
 - Are built to store a lot of energy → hysteresis curve spans a large area
 - Core losses depend on amplitude and frequency of the ripple current

- Winding losses
 - Arise from the ohmic resistance of the winding
 - Dissipated power is proportional to I^2
 - Winding resistance increases approx. 0.4% per K (for Cu)
- Keep losses and temperatures low because
 - Higher tempeatures cause even higher losses
 - Wasted energy
 - Costs of the wasted energy
 - Costs for recooling
 - Lower temperatures increase the life time
 - The investments will be returned

Heat Sources: Semiconductors

- IGBT losses
 - Conduction losses
 - (Blocking losses)
 - Switching losses (ON and OFF)
- Diode losses
 - Conduction losses
 - (Blocking losses)
 - Switching losses (Recovery losses)

Example:



FF600R06ME3 [1]

$$V_{DC} = 250V$$

$$I_{Out} = 200A \text{ @ } m = 0.8$$

$$f_s = 20\text{kHz}$$

Heat Sources: IGBT losses

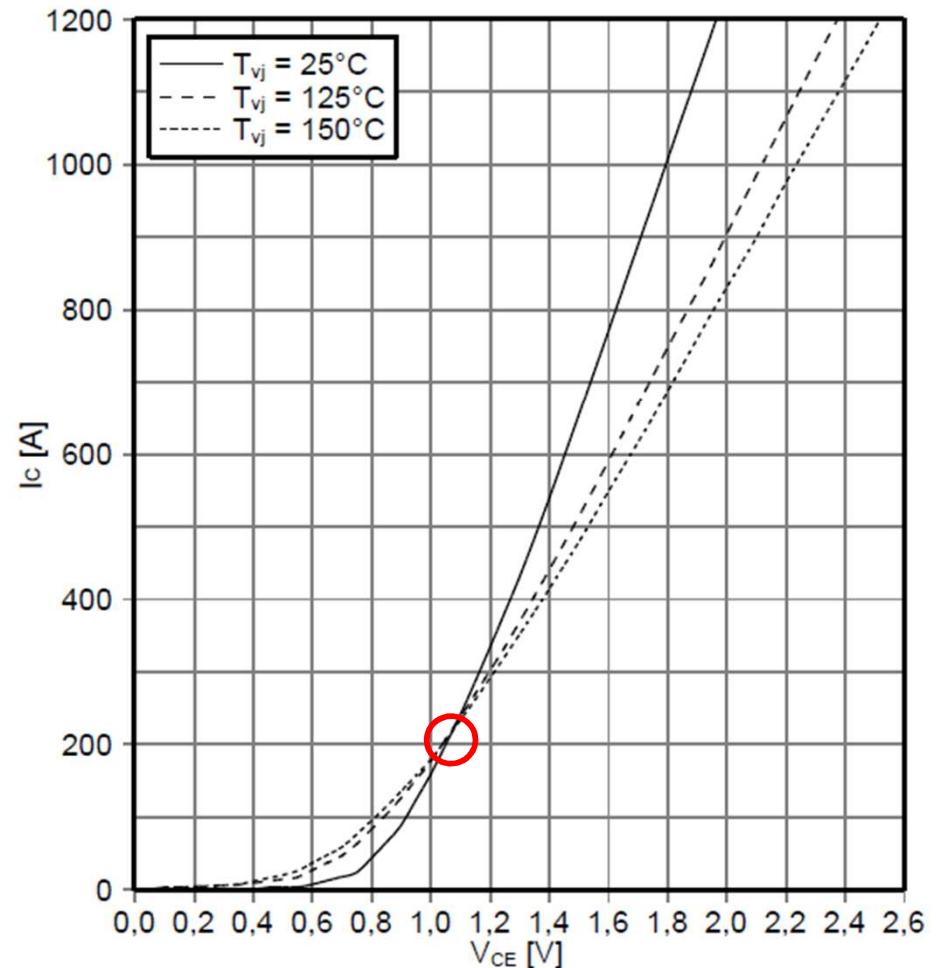
Conduction losses IGBT:

$$P_{CI} = m \cdot I_{out} \cdot V_{CE}$$

Note: V_{CE} depends on the junction temperature

$$P_{CI} = 0.8 \cdot 200A \cdot 1.1V = 176W$$

Ausgangskennlinie IGBT, Wechselrichter (typisch)
output characteristic IGBT, Inverter (typical)
 $I_C = f(V_{CE})$
 $V_{GE} = 15 V$



Heat Sources: IGBT losses

Switching losses IGBT:

$$P_{SI} = f_s \cdot (E_{on} + E_{off}) \cdot \left(\frac{V_{DC}}{V_{ref}} \right)^{K_V} \cdot K_T$$

with $K_V = 1.3 \dots 1.4$

and $K_T = 1 + 0.003K^{-1} \cdot (T_J - T_{Ref})$ [2]

In our example we assume $T_J \approx 90^\circ\text{C}$

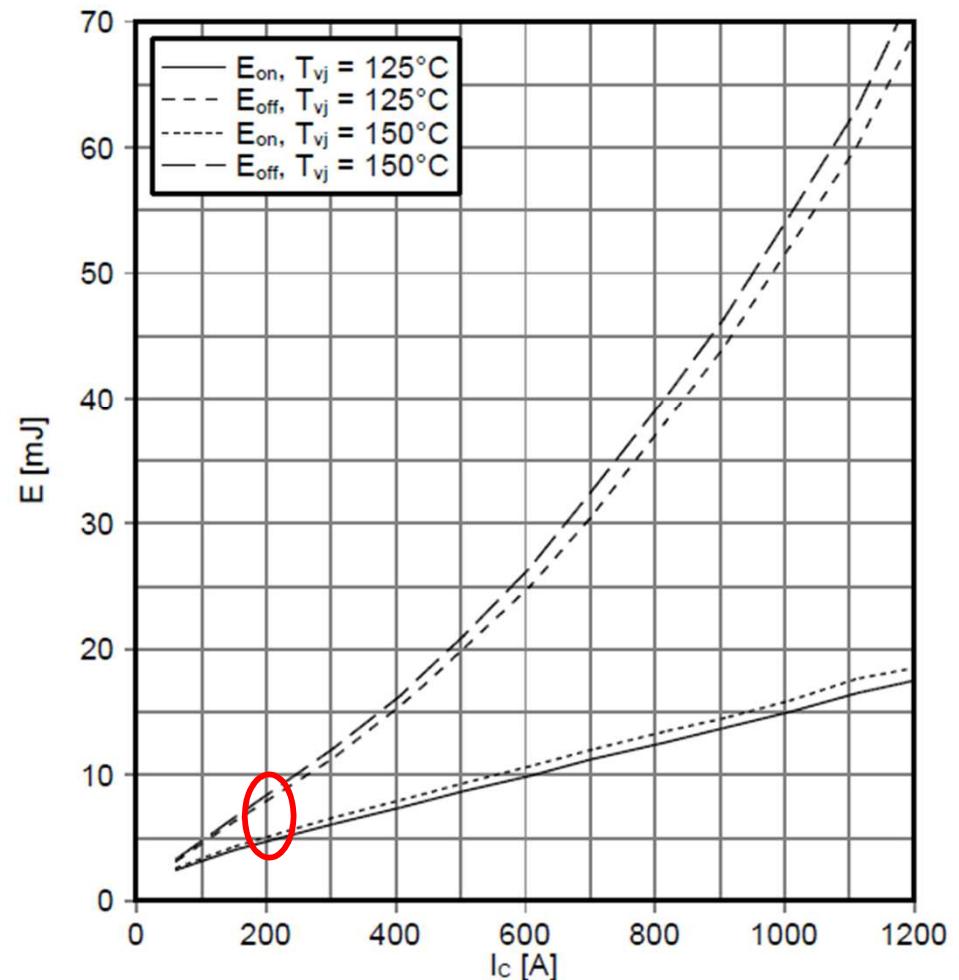
$$K_T = 1 + 0.003K^{-1} \cdot (90 - 125)$$

$$K_T = 0.895$$

$$P_{SI} = 20'000s^{-1} \cdot (5 + 8) \cdot 10^{-3}J$$

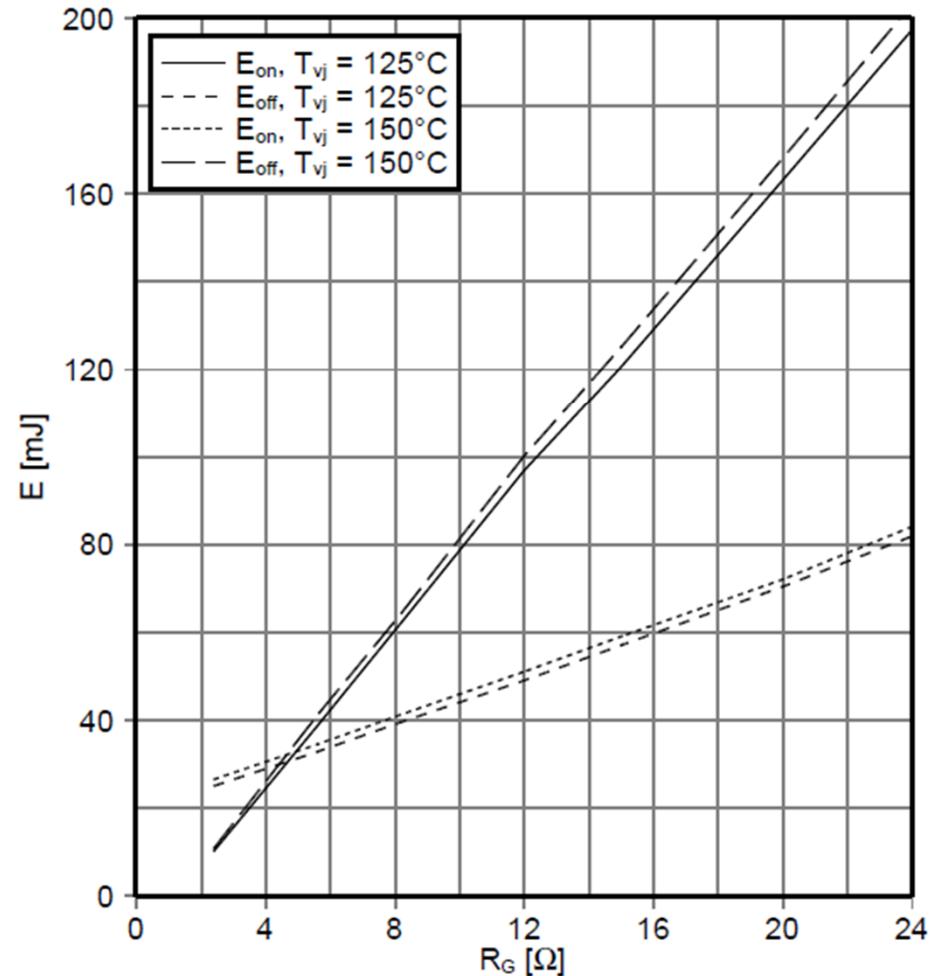
$$\cdot \left(\frac{250V}{300V} \right)^{1.35} \cdot 0.895 = 182W$$

Schaltverluste IGBT, Wechselrichter (typisch)
switching losses IGBT, Inverter (typical)
 $E_{on} = f(I_c)$, $E_{off} = f(I_c)$
 $V_{GE} = \pm 15\text{ V}$, $R_{Gon} = 2.4\Omega$, $R_{Goff} = 2.4\Omega$, $V_{CE} = 300\text{ V}$



Heat Sources: IGBT losses

Schaltverluste IGBT, Wechselrichter (typisch)
switching losses IGBT, Inverter (typical)
 $E_{on} = f(R_G)$, $E_{off} = f(R_G)$
 $V_{GE} = \pm 15 \text{ V}$, $I_C = 600 \text{ A}$, $V_{CE} = 300 \text{ V}$



A softer switching (higher gate resistance) increases the switching losses dramatically

Heat Sources: Diode losses

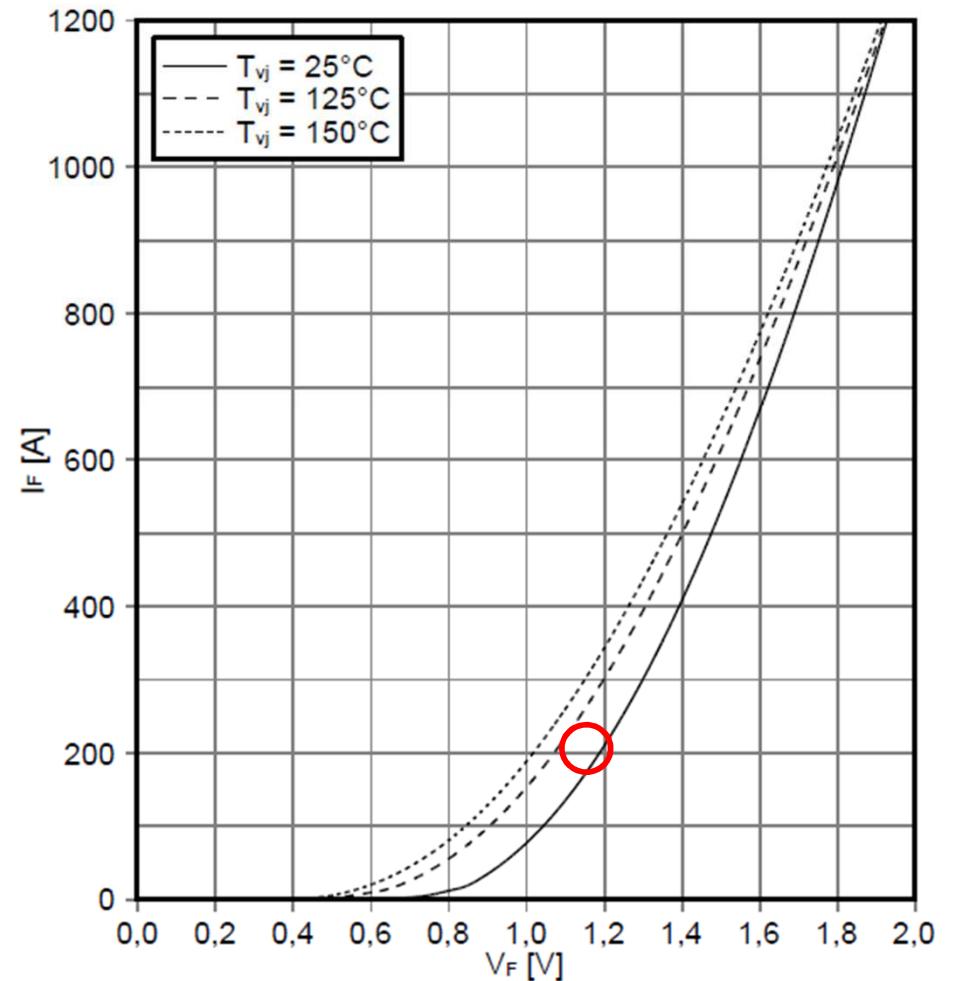
Conduction losses Diode

$$P_{CD} = (1 - m) \cdot I_{out} \cdot V_F$$

Note: Negative temperature coefficient!

$$P_{CD} = (1 - 0.8) \cdot 200A \cdot 1.15V = 46W$$

Durchlasskennlinie der Diode, Wechselrichter (typisch)
forward characteristic of Diode, Inverter (typical)
 $I_F = f(V_F)$



Heat Sources: Diode losses

Switching losses Diode

$$P_{SD} = f_s \cdot E_{Rec} \cdot \left(\frac{V_{DC}}{V_{ref}} \right)^{K_V} \cdot K_T$$

with $K_V = 0.6$

and $K_T = 1 + 0.006K^{-1} \cdot (T_J - T_{Ref})$ [2]

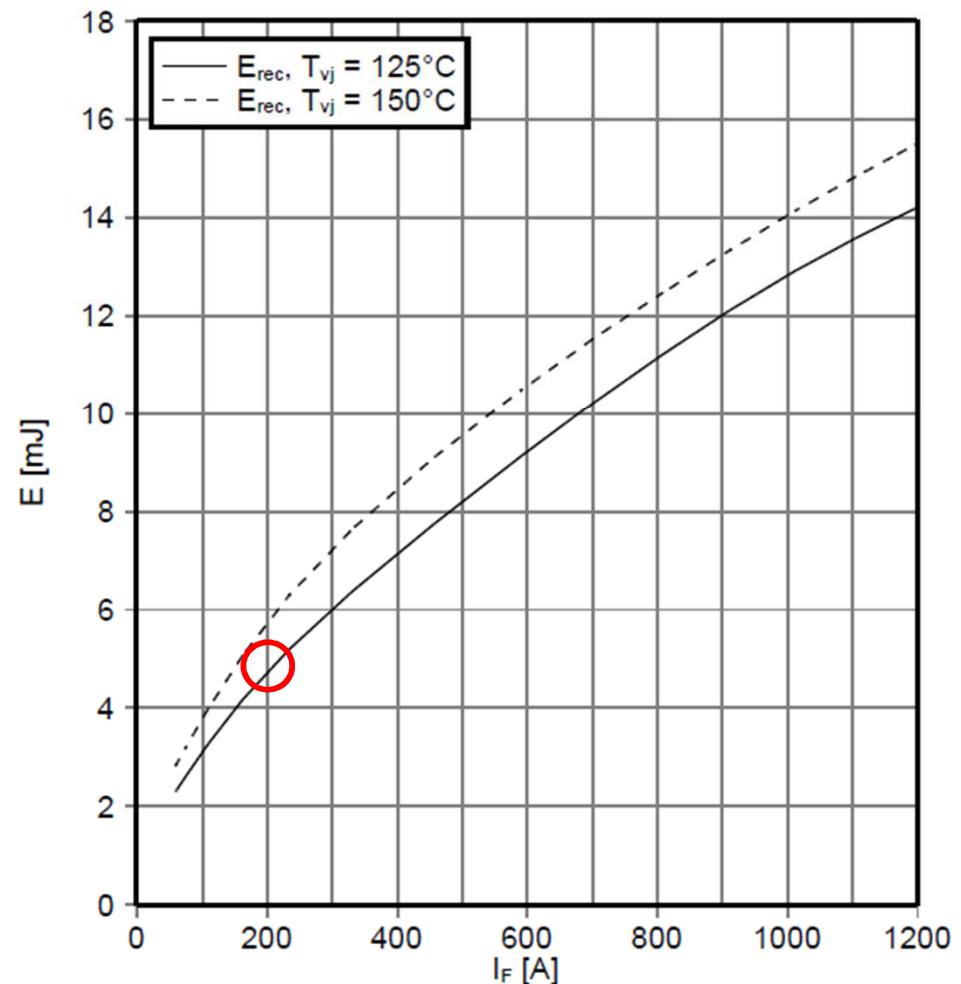
In our example we assume $T_J \approx 90^\circ\text{C}$

$$K_T = 1 + 0.006K^{-1}(90 - 125)$$

$$K_T = 0.79$$

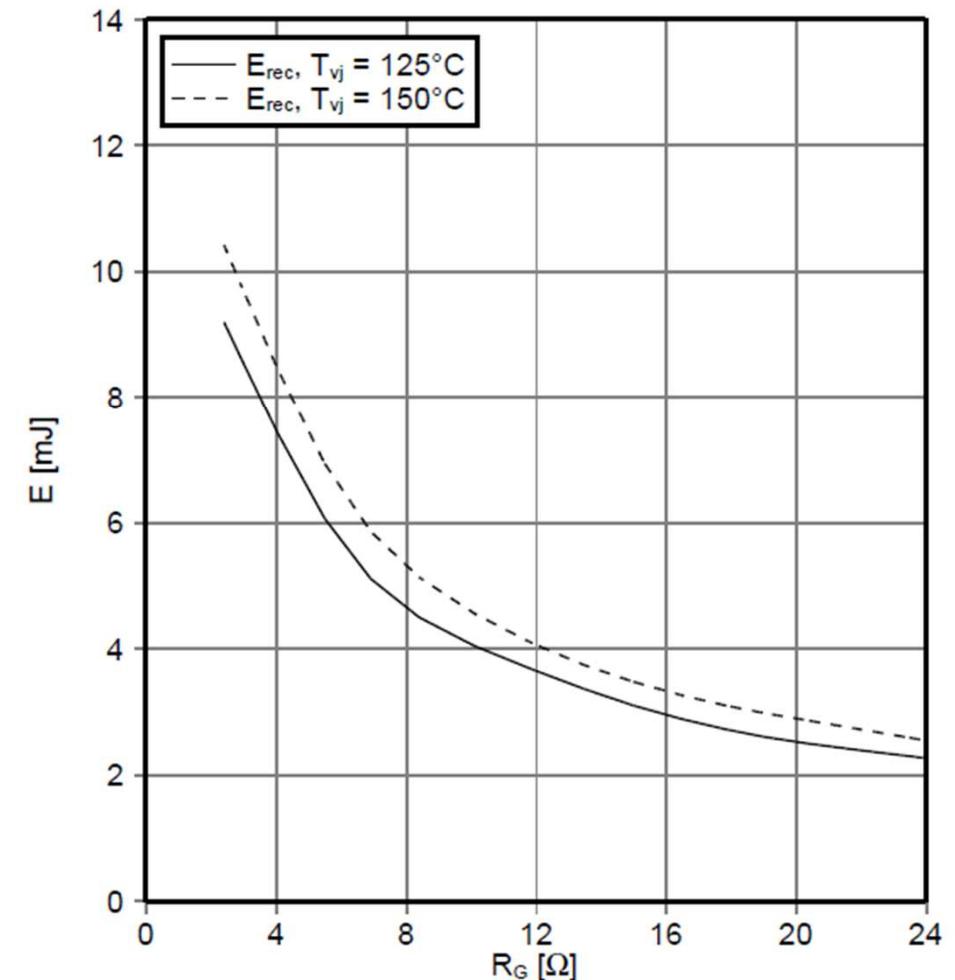
$$\begin{aligned} P_{SD} &= 20'000s^{-1} \cdot 5 \cdot 10^{-3}J \cdot \left(\frac{250V}{300V} \right)^{0.6} \cdot 0.79 \\ &= 71 W \end{aligned}$$

Schaltverluste Diode, Wechselrichter (typisch)
switching losses Diode, Inverter (typical)
 $E_{rec} = f(I_F)$
 $R_{Gon} = 2.4 \Omega, V_{CE} = 300 \text{ V}$



Heat Sources: Diode losses

Schaltverluste Diode, Wechselrichter (typisch)
switching losses Diode, Inverter (typical)
 $E_{rec} = f(R_G)$
 $I_F = 600 \text{ A}, V_{CE} = 300 \text{ V}$



In contrary to the IGBT, a softer switching (higher gate resistance) reduces the switching losses of the freewheeling diode remarkably.

Summary losses

IGBT losses

$$P_I = P_{CI} + P_{SI}$$

$$P_I = 176W + 182W = 358W$$

Diode losses

$$P_D = P_{CD} + P_{SD}$$

$$P_D = 46W + 71W = 117W$$

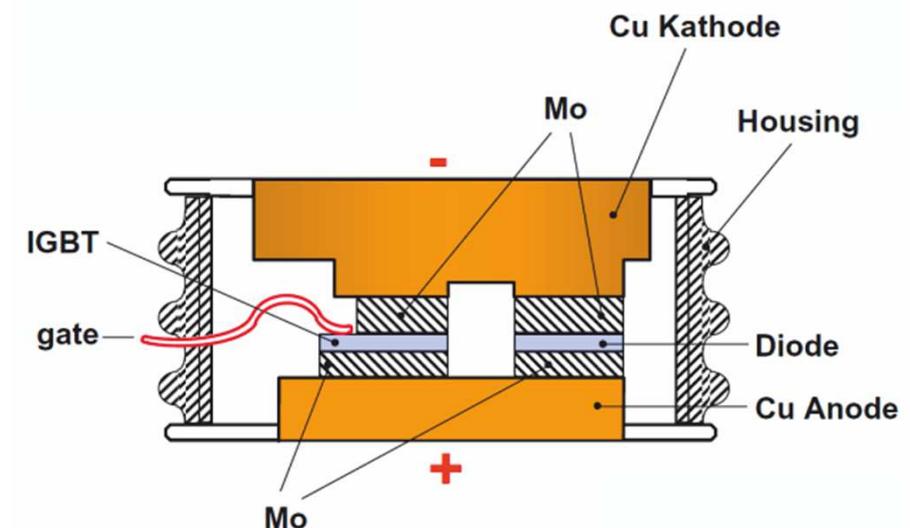
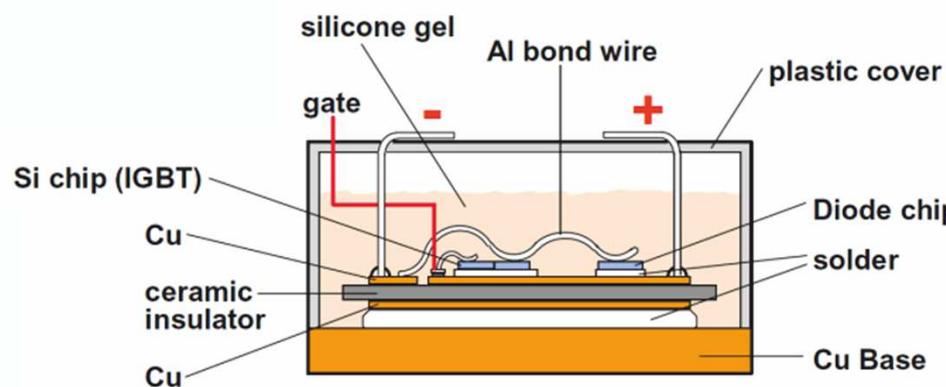
Total losses per module

$$P = P_I + P_D$$

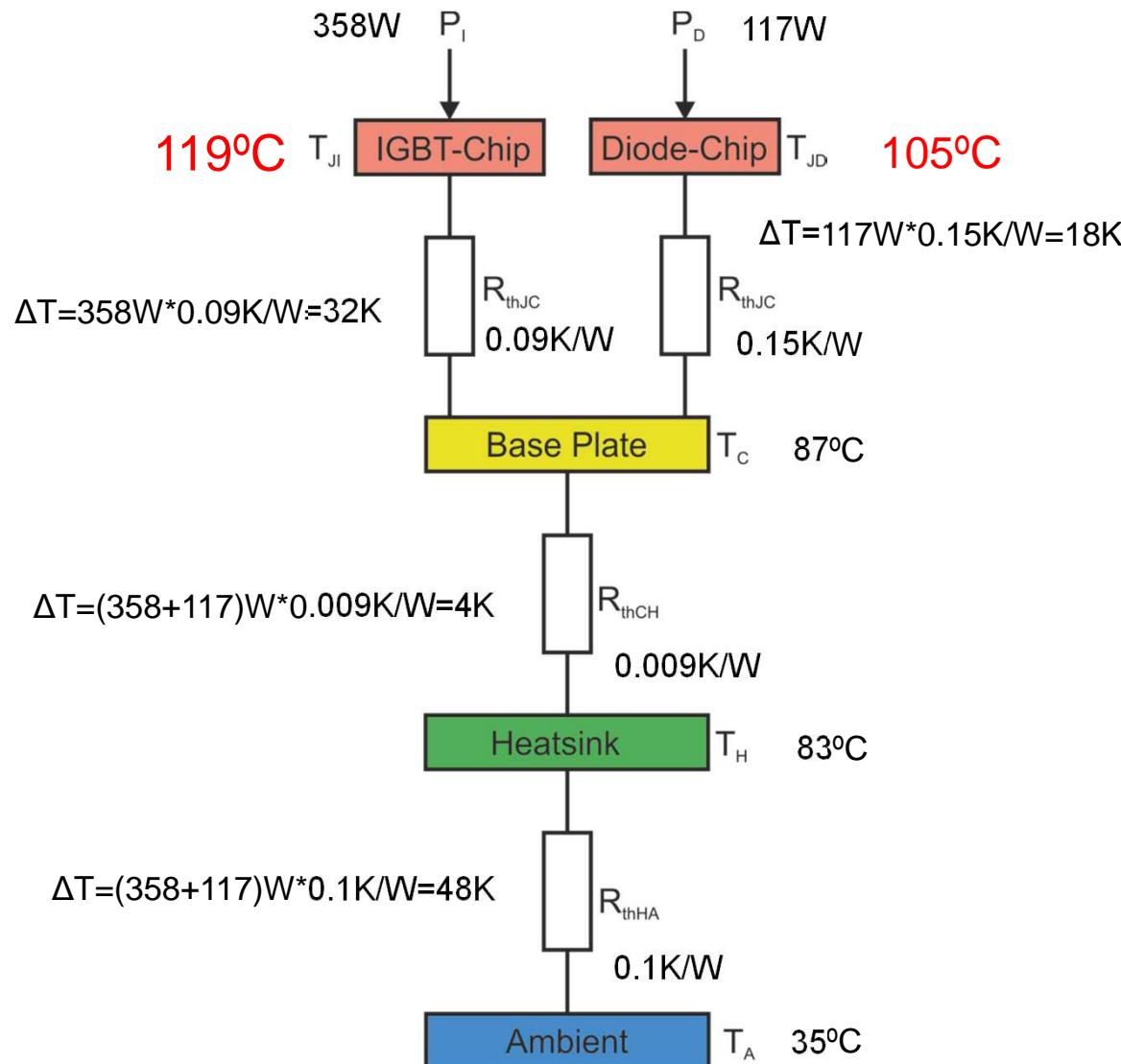
$$P = 358W + 117W = 475W$$

Heat transfer: Packages

- Isolated module package
 - Isolated Cu Base
 - 1 heat sink for several devices
 - Heat sink on ground potential
 - Solder contacts
 - Cooling from one side only
 - Open circuit after failure
 - Parallel connection
- Press pack devices
 - Cooling via power terminals
 - Individual heat sinks for all devices
 - Heat sink on high voltage
 - Presspack contacts
 - Cooling from both sides
 - Short circuit after failure
 - Series connection

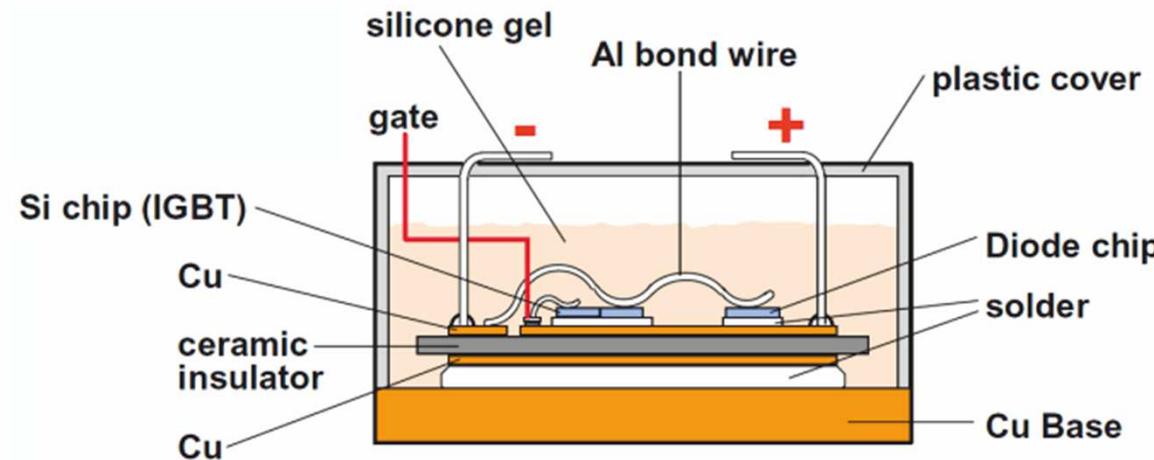


Heat transfer: Temperatures

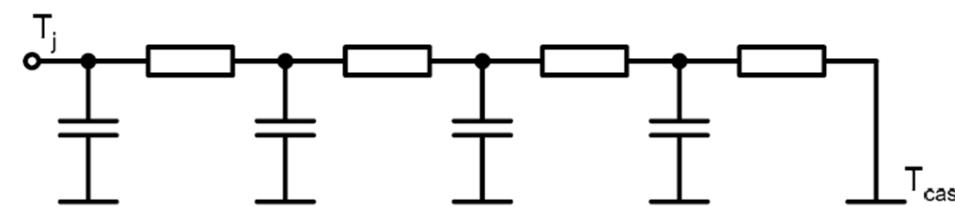


- Maximum ambient temperature
- Get thermal resistances from module data sheet
- Get thermal resistance from heat sink supplier
- IGBT- and diode-losses from calculation
- Calculate heatsink temperature
- Calculate base plate temperature
- Calculate diode and IGBT chip temperatures
- **There should be a safety margin of min. 25K!**

Transient thermal impedance

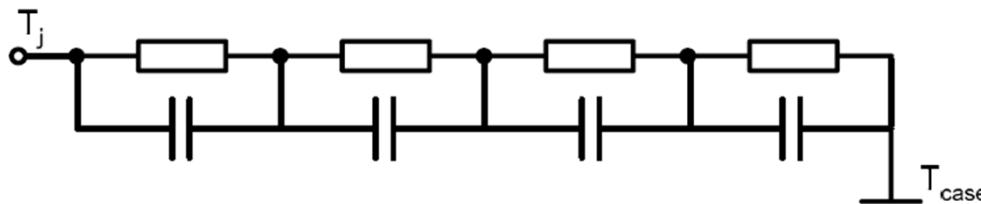


Continued fraction circuit (Cauer model)



Transient thermal impedance

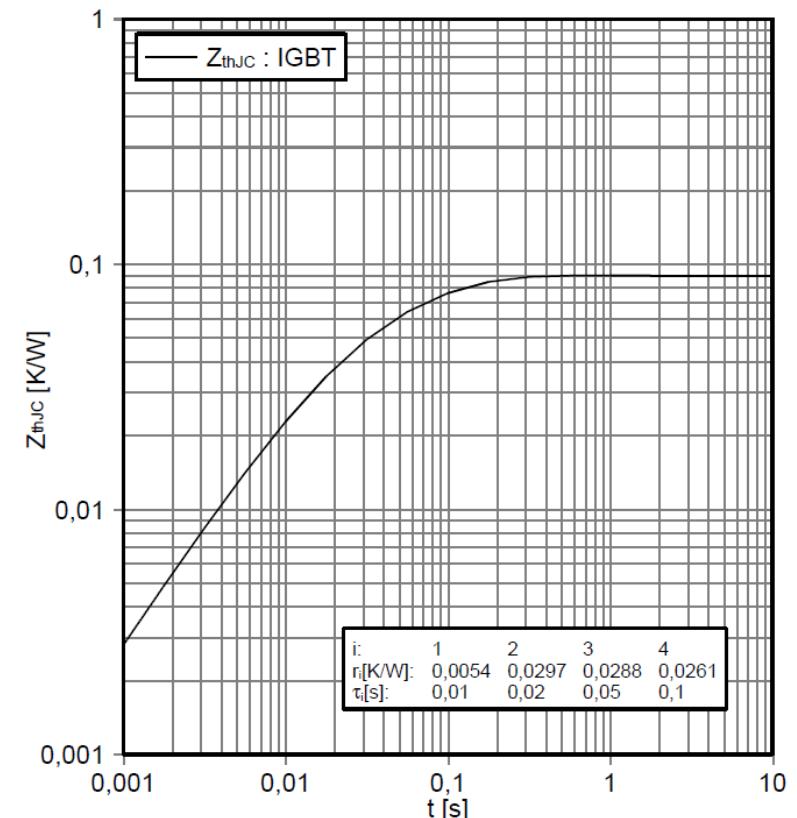
Partial fraction circuit (Foster model)



$$Z_{thjc}(t) = \sum_{i=1}^n r_i \cdot \left(1 - e^{-\frac{t}{\tau_i}} \right)$$

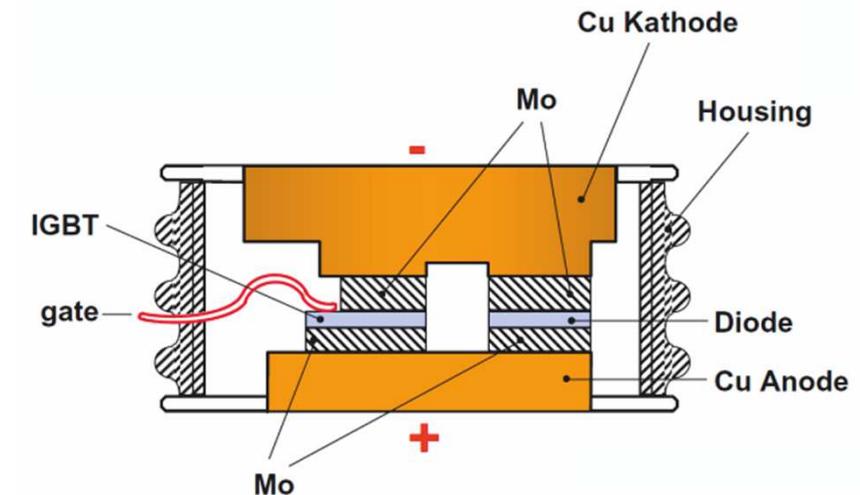
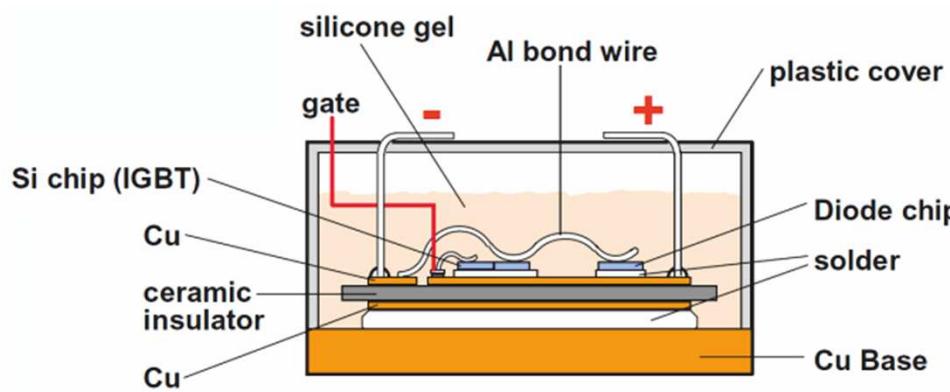
$$T_j(t) = P(t) \cdot Z_{thjc}(t) + T_{case}(t)$$

Transienter Wärmewiderstand IGBT, Wechselrichter
transient thermal impedance IGBT, Inverter
 $Z_{thjc} = f(t)$



Stacking of different materials

Material	Expansion coefficient α [10 ⁻⁶ /K]
Silicon	4.1
Copper	17
Aluminum	24
Molybdenum	5
Solder	15 - 30
Ceramic	5 - 9

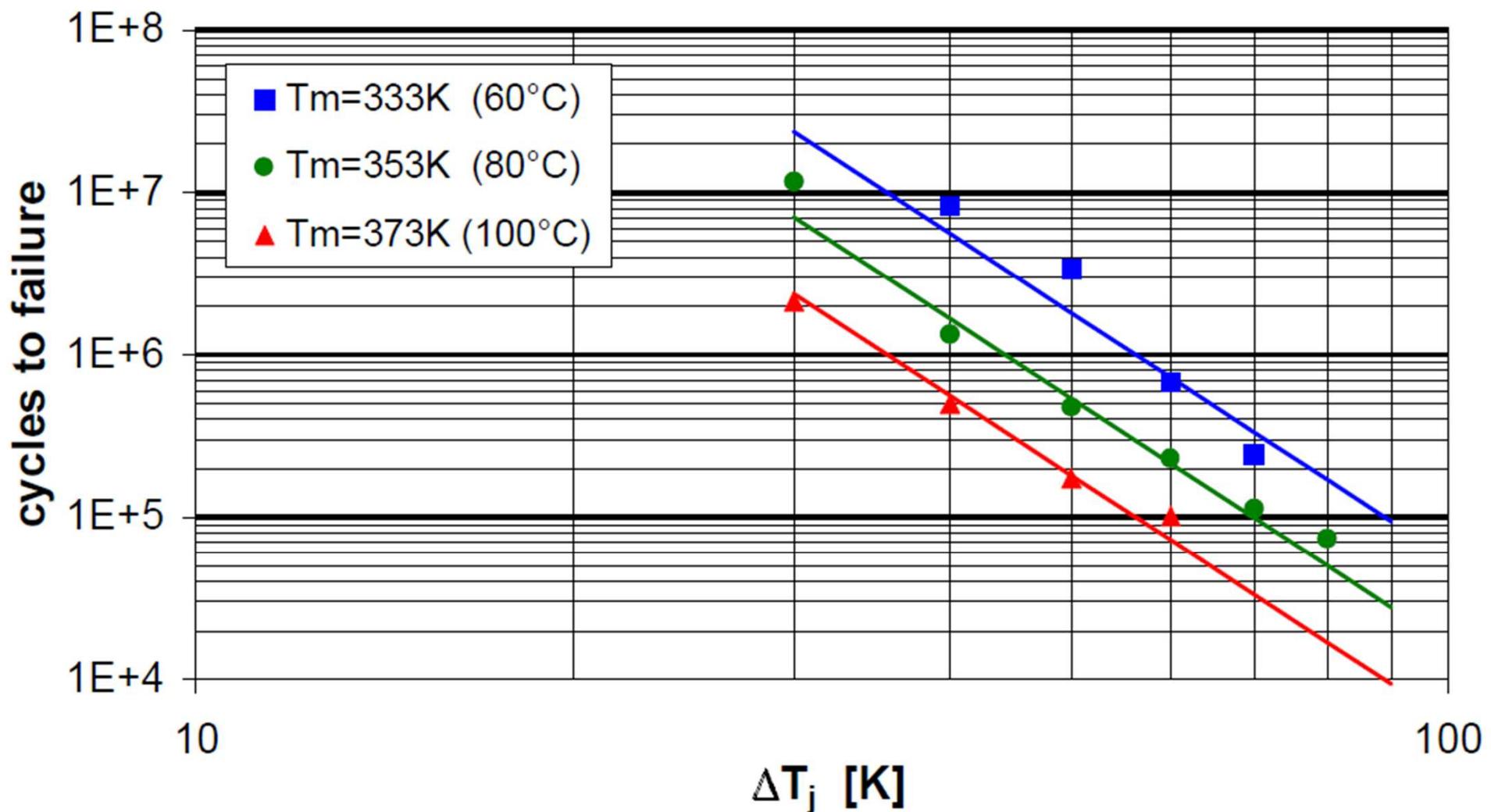


Temperature variations

- Power Cycling
 - Temperature variations of the silicon chips (fast)
 - Causes mechanical stress to bond wires
 - Bond wires lift off
 - V_{CE} increases
 - Losses increase
 - Larger temperature variations
 - Device fails
- Thermal Cycling
 - Temperature variations of the base plate (slow)
 - Causes mechanical stress to soldering joint
 - Aging of soldering joint
 - R_{th} increases
 - Larger temperature variations
 - Device fails

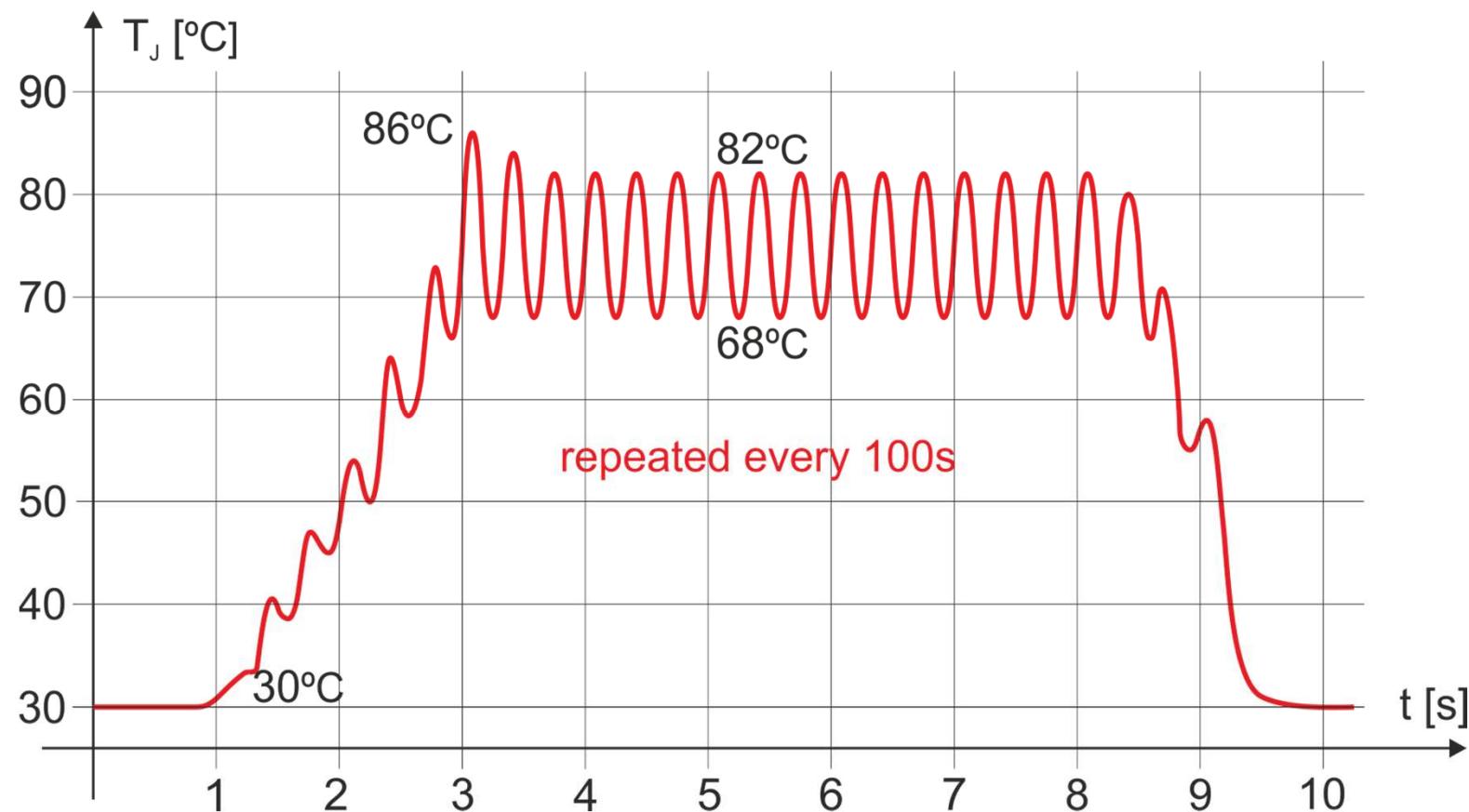
LESIT Project

Power Cycling of standard modules from various manufacturers (~1995)



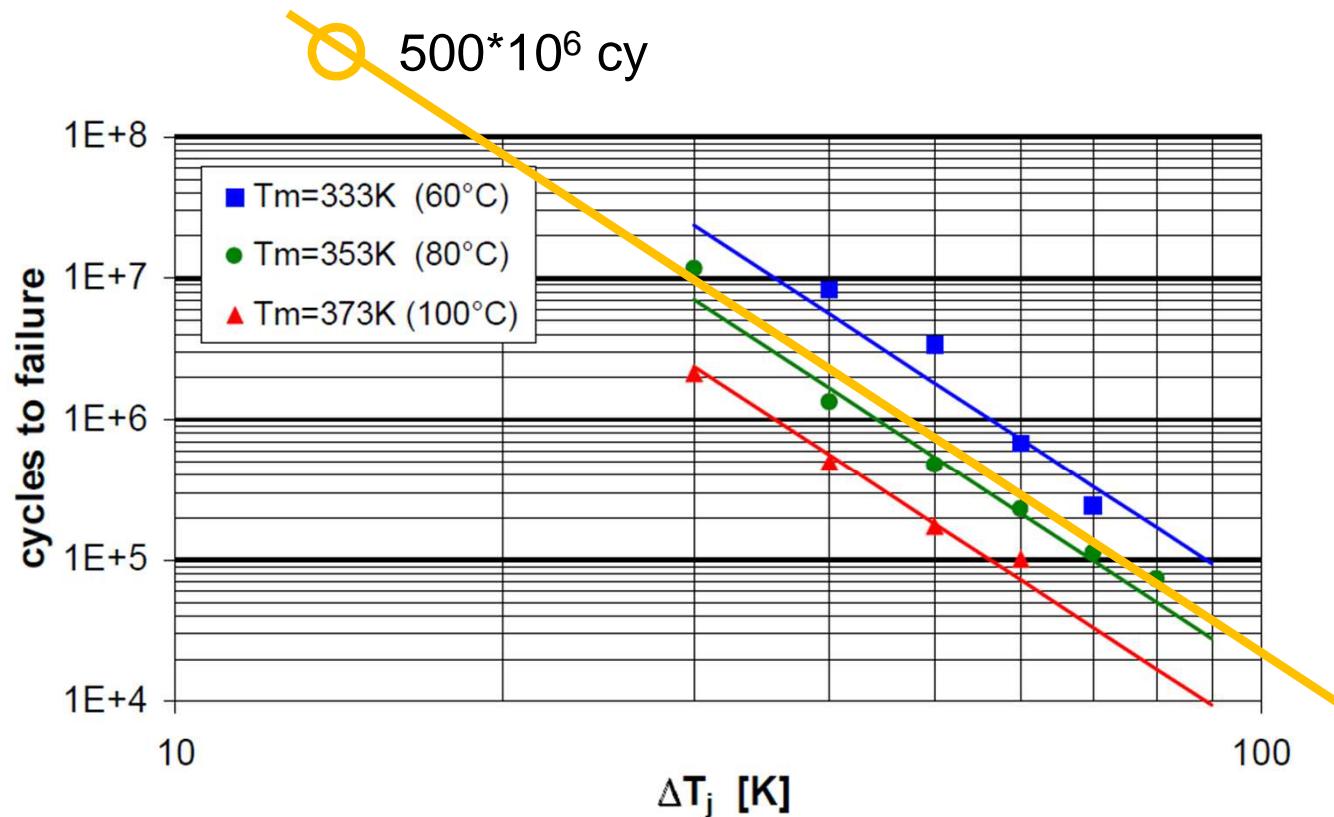
Practical Experience (1)

- SLS Booster Dipole Power Supply in Topup Mode
 - Junction temperature variations
 - IGBT failures after 3.5a of operation



Practical Experience (2)

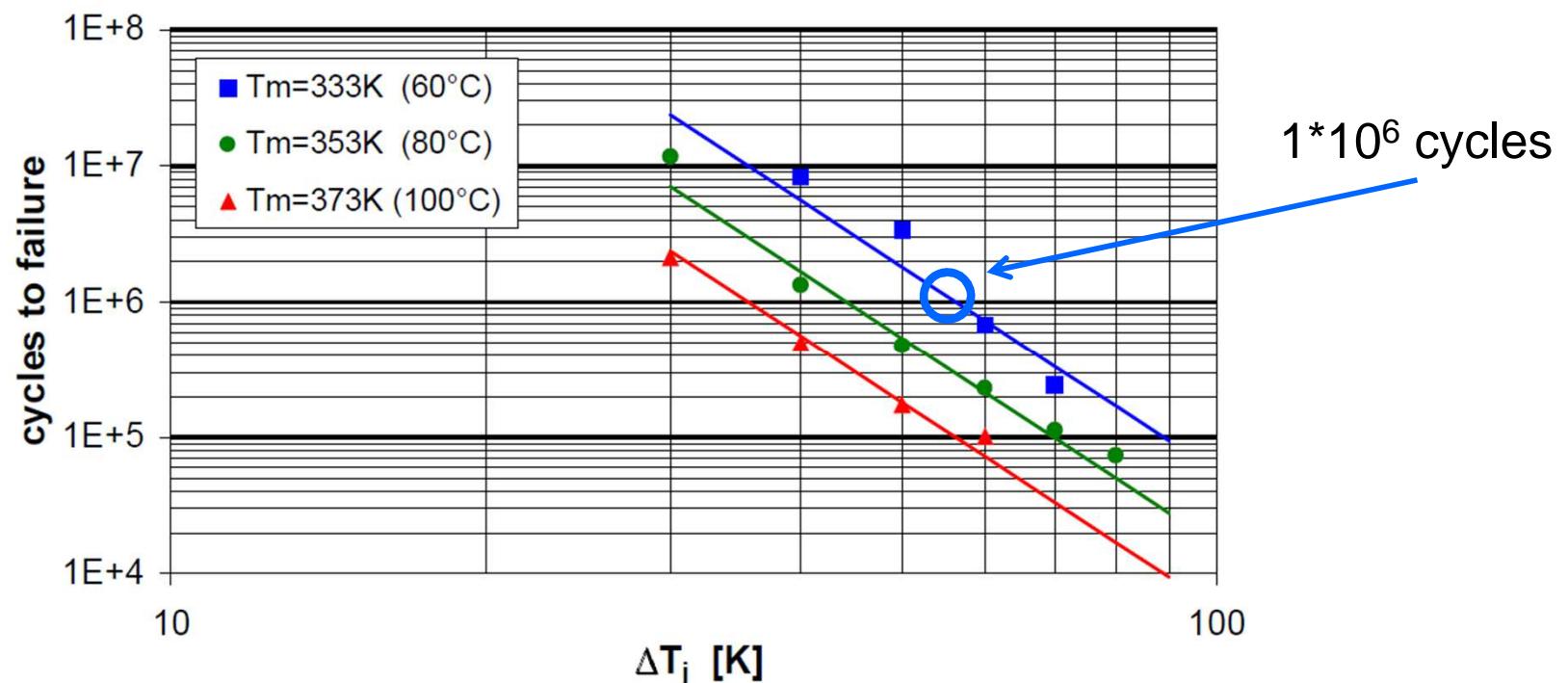
- 3Hz Oscillations: 68.....82°C $\Delta T_j = 14K$, $T_m = 75^\circ C$
 - 40 weeks/a, continuous $\rightarrow 80 \cdot 10^6$ cy/a \rightarrow 6a to failure
 - 40 weeks/a, 16cy every 100s $\rightarrow 15 \cdot 10^6$ cy/a \rightarrow 33a to failure
 - Extreme extrapolation: Result valid ???



Practical Experience (3)

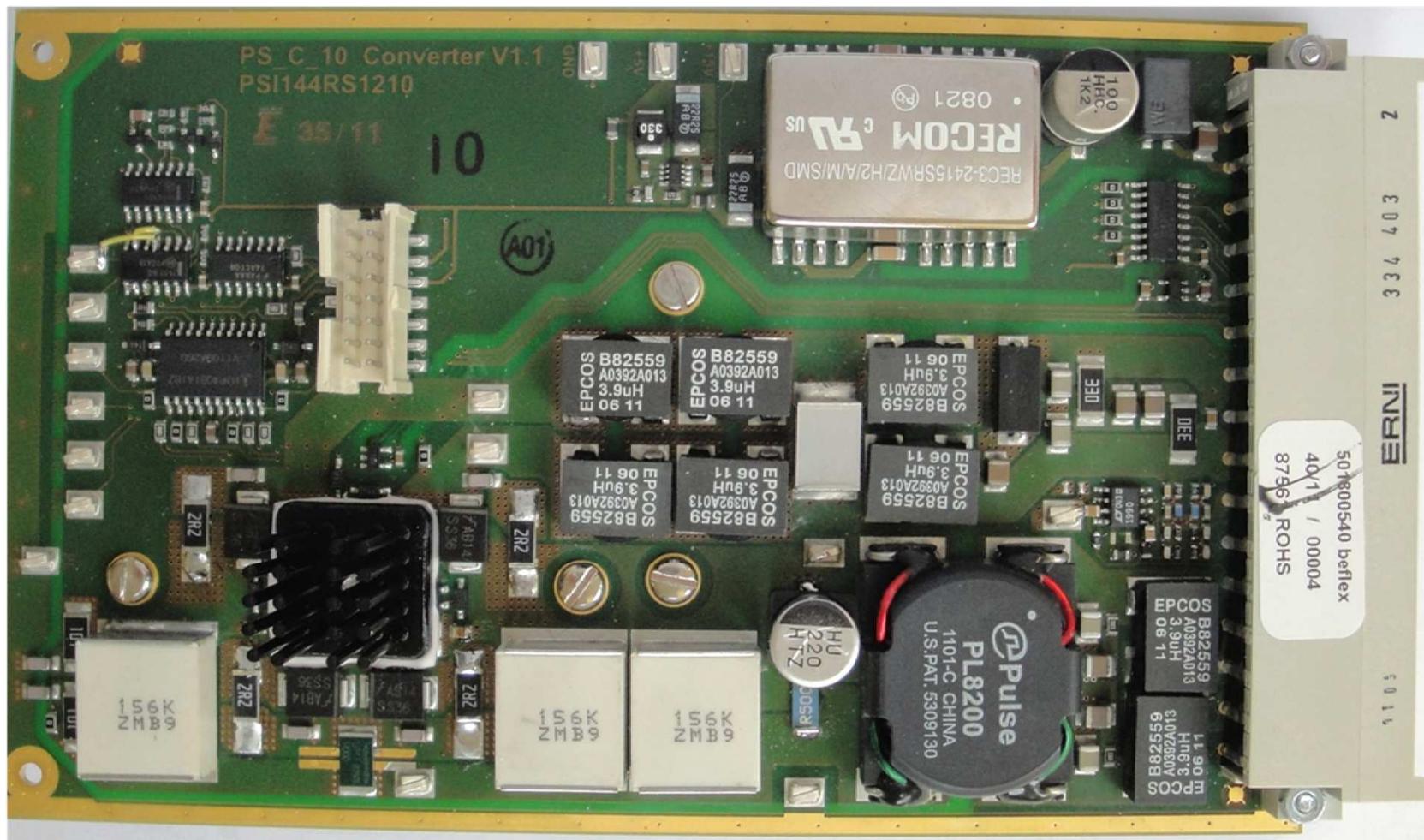
- 100s Oscillations: 30.....86°C $\Delta T_j = 56K$, $T_m = 58^\circ C$
 - 40 weeks/a, 1cy every 100s $\rightarrow 0.25 \cdot 10^6$ cy/a $\rightarrow 4a$ to failure

that is, what we have experienced!



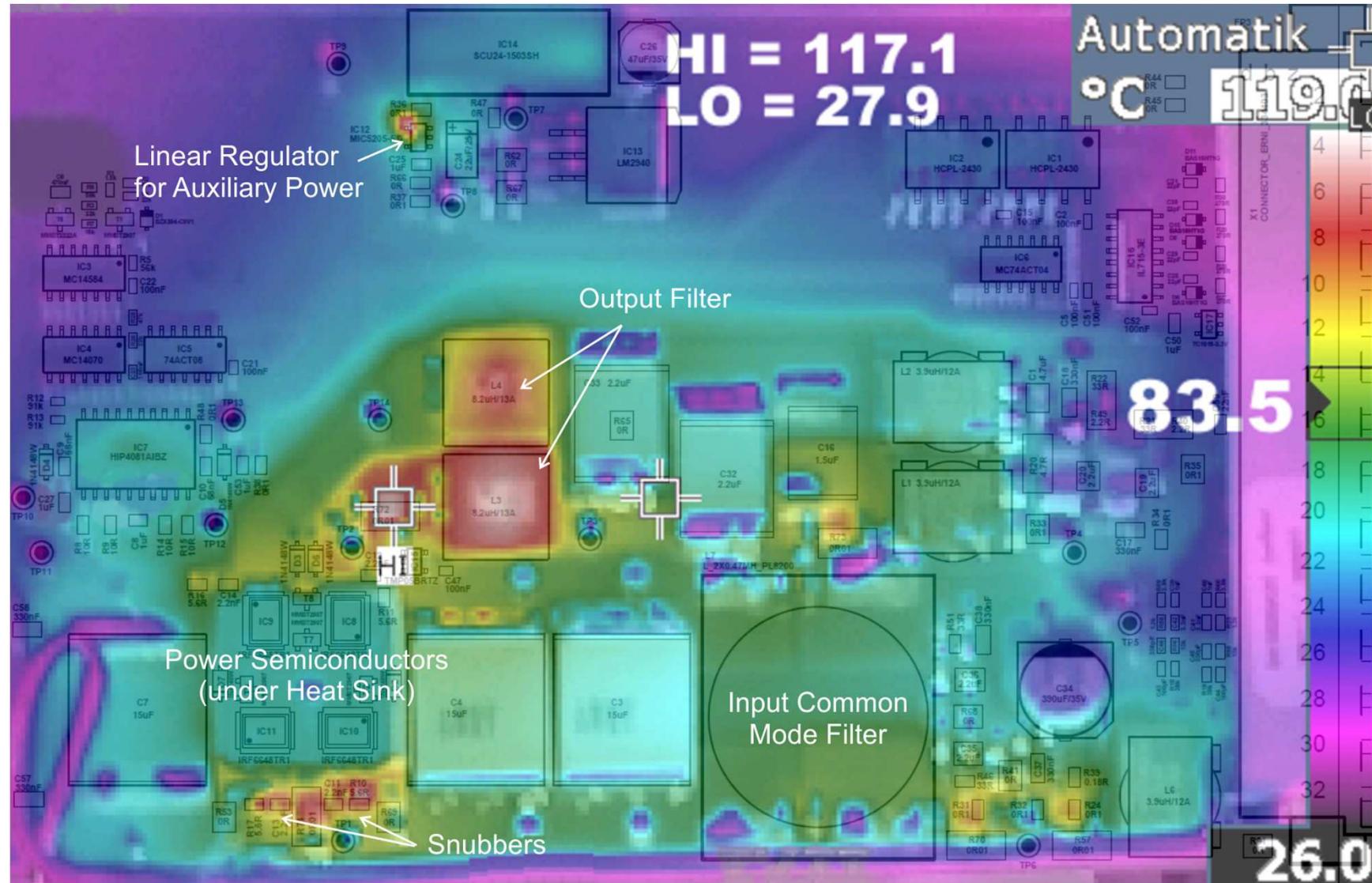
Thermal Design of a PCB

10A H-bridge on a PCB 100mm 160mm

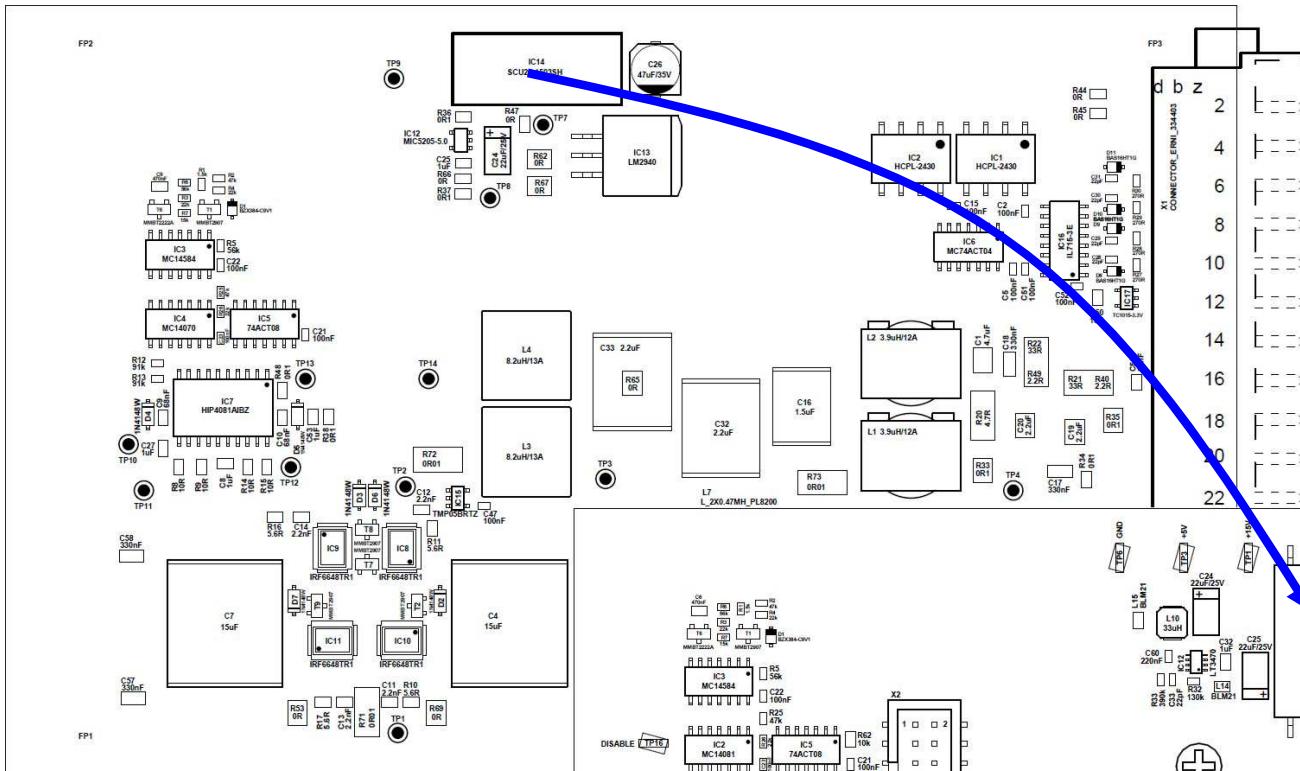


First prototype

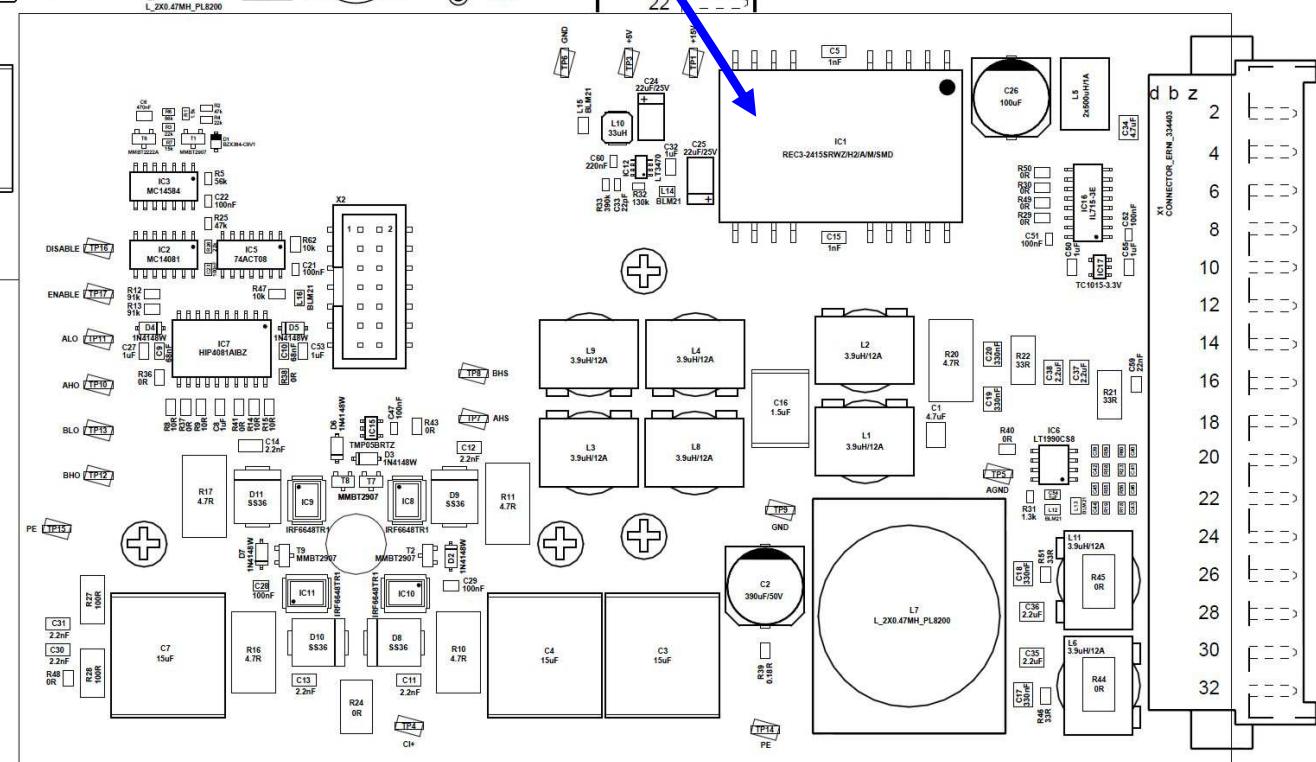
Infrared image at full load



Replace DC/DC converter 24V/15V

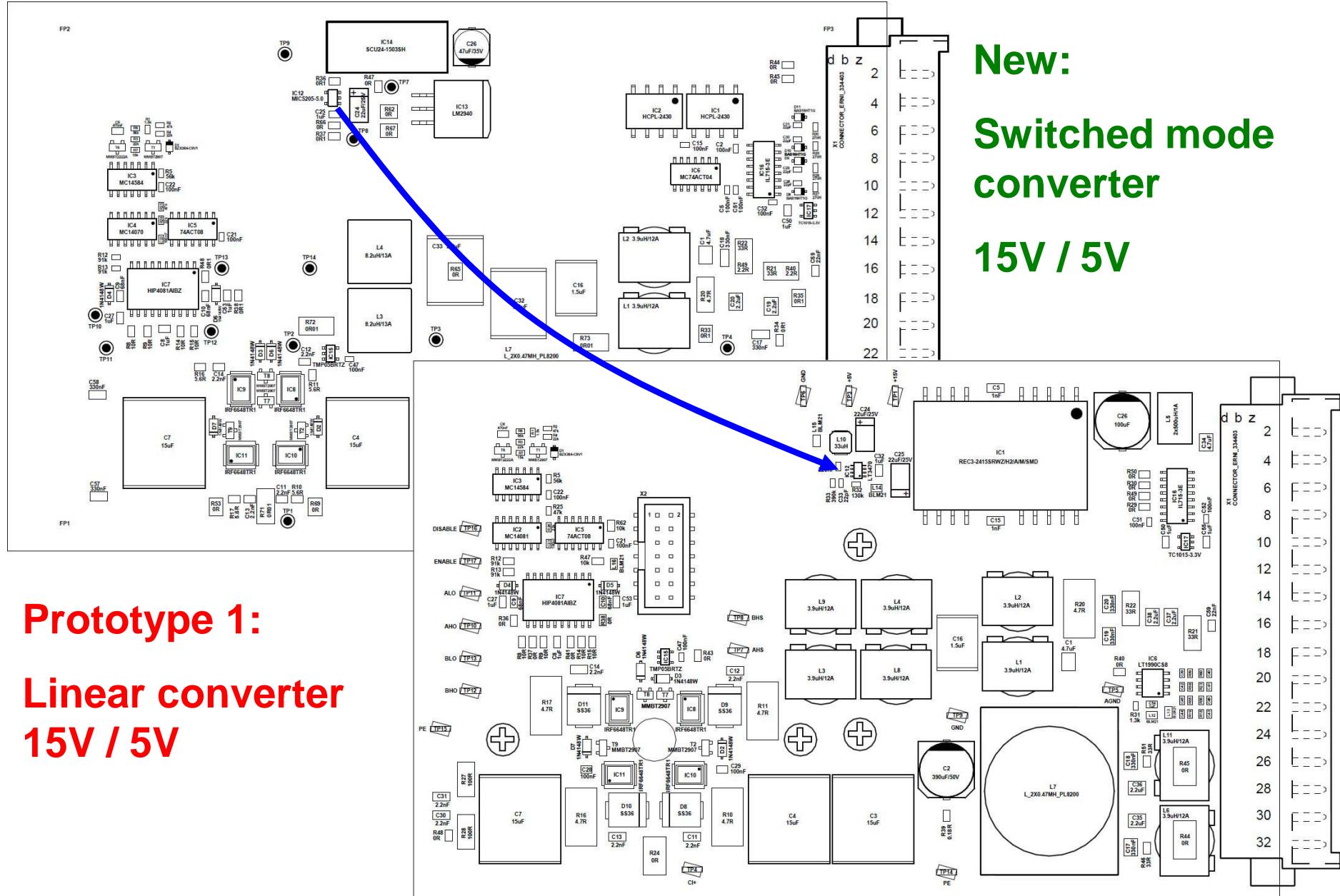


Prototype 1:
THT DC/DC-
converter in a
plastic case

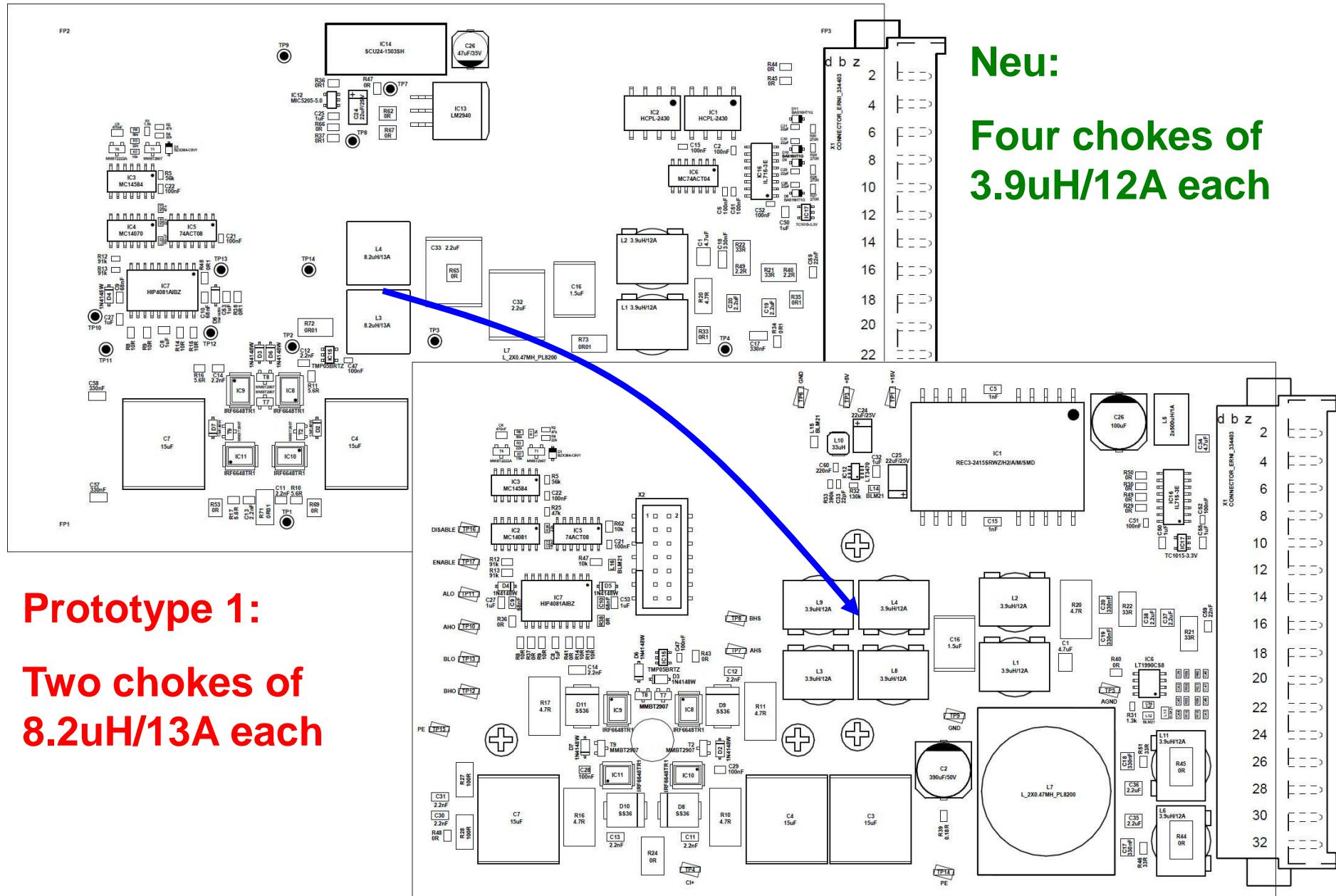


New:
SMD DC/DC-
converter in a
metallic case

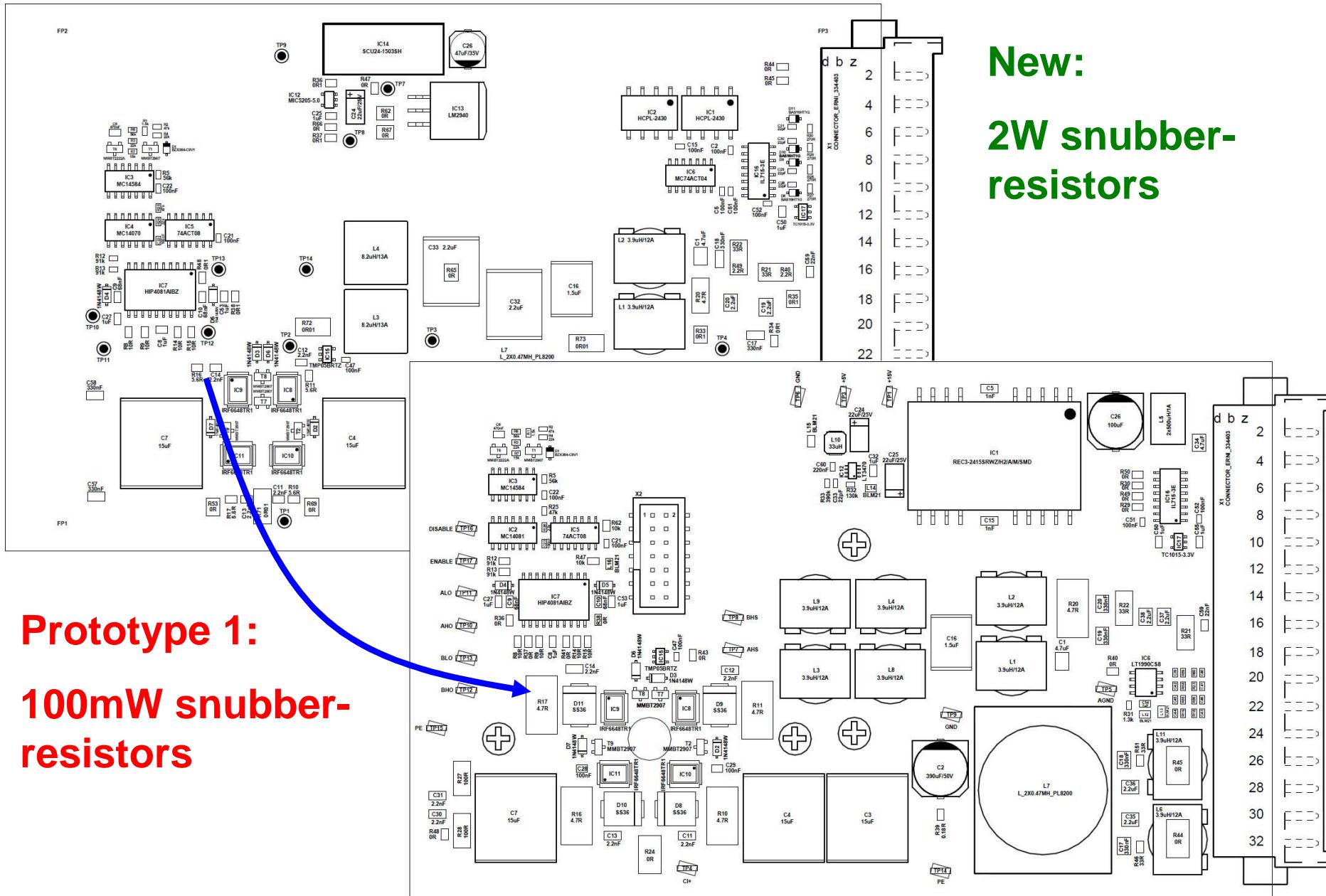
Replace DC/DC converters 15V/5V



Replace filter chokes



Replace snubber resistors



Improve heat flow

- Thermal conductivity of different materials λ [W/K m]

– Gold	318
– Silver	429
– Copper	401
– Aluminum	237
– Steel	50
– Heat transfer foil	2
– PCB core material (FR-4)	0.3
– Air	0.025

Improve heat flow

- Heat path through the PCB

- Mounting area of semiconductors $A = 2\text{cm} \times 2\text{cm} = 4\text{cm}^2$
- Distance from top to bottom layer $l = 1.6\text{mm}$
- Thermal conductivity PCB core (FR-4) $\lambda = 0.3 \text{ W/K m}$
- Total losses in the semiconductors $P \approx 10\text{W}$

- Thermal resistance: $R_{th} = \frac{l}{\lambda \cdot A} = \frac{1.6\text{mm} \cdot m \cdot K}{0.3\text{W} \cdot 4\text{cm}^2} = 13.3 \frac{K}{W}$

- Temp. difference
Top - Bottom

$$\Delta T = R_{th} \cdot P = 13.3 \frac{K}{W} \cdot 10\text{W} = 133K$$

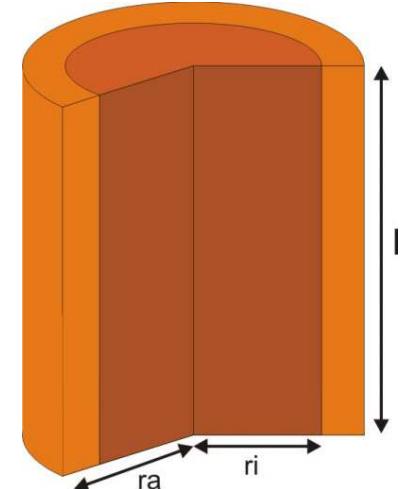


Improve heat flow

- Additional heat path through vias

- Outside radius $ra = 0.175\text{mm}$
- Inside radius $ri = 0.15\text{ mm}$
- Via height $l = 1.6\text{ mm}$
- Thermal conductivity of Cu $\lambda = 400 \text{ W/K m}$

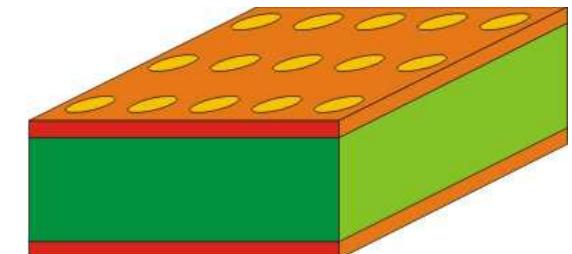
$$A = (ra^2 - ri^2) \cdot \pi = ((0.175\text{mm})^2 - (0.15\text{mm})^2) \cdot \pi = 0.0255\text{mm}^2$$



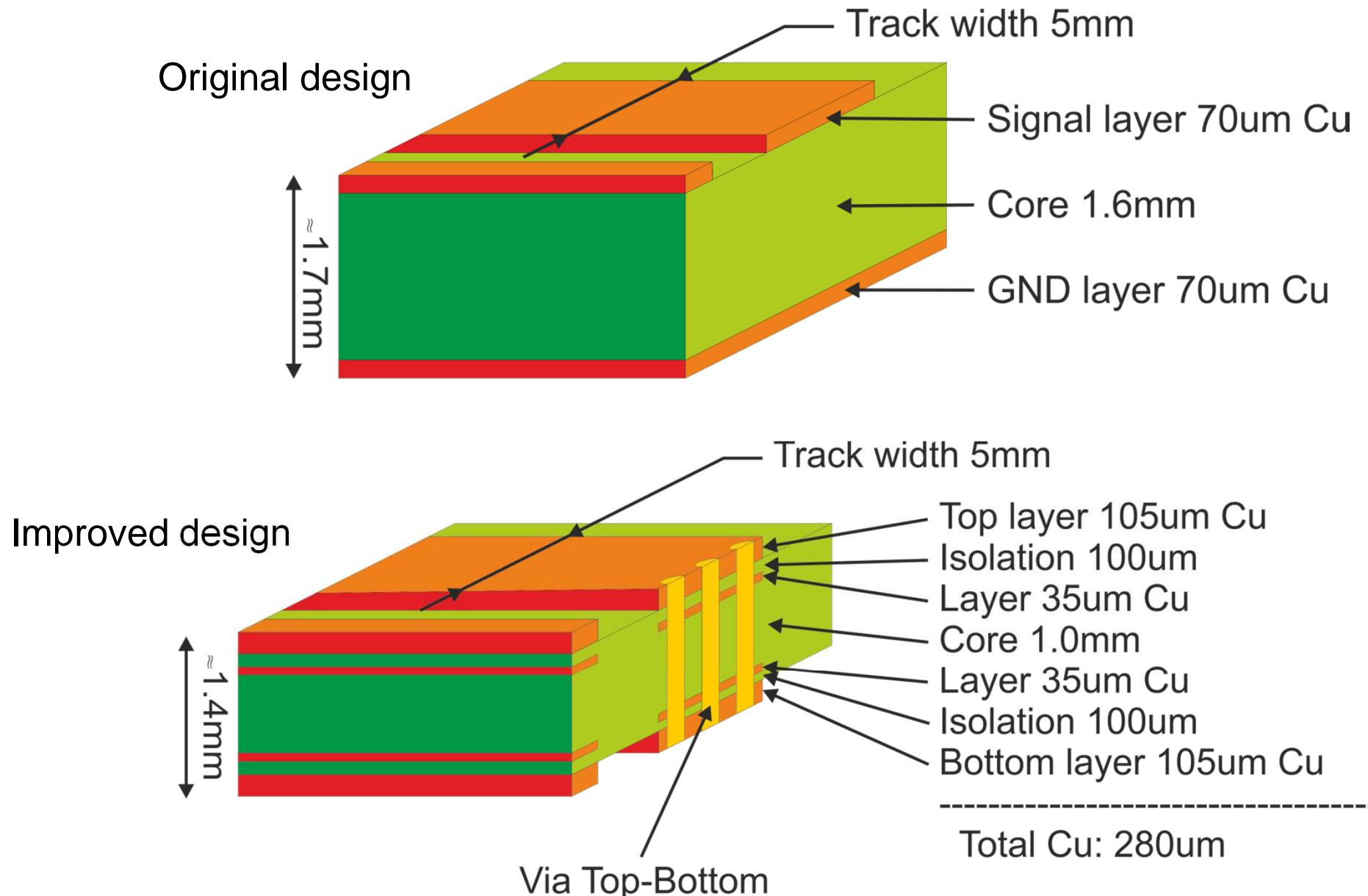
$$R_{th} = \frac{l}{\lambda \cdot A} = \frac{1.6\text{mm} \cdot \text{m} \cdot K}{400\text{W} \cdot 0.0255\text{mm}^2} = 156.8 \frac{K}{W}$$

- On 4 cm^2 there is space for $8 \times 8 = 64$ vias
- Thermal resistance of 64 vias: $R_{th} = 2.45K / W$
- Temperature difference Top - Bottom

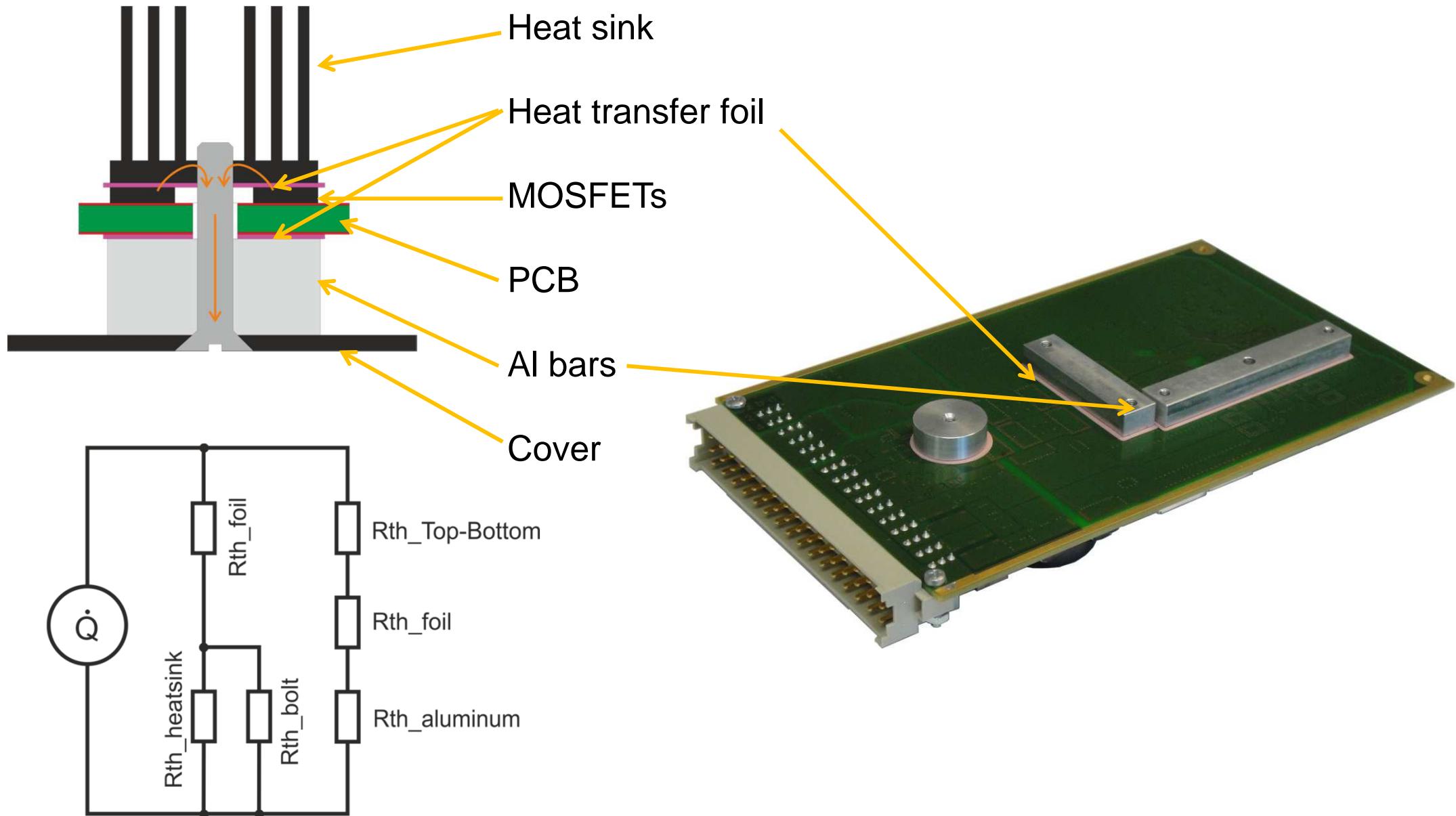
$$\Delta T = P \cdot \frac{1}{\frac{1}{R_{th-LP}} + \frac{1}{R_{th-Via}}} = 10W \cdot \frac{1}{\frac{1 \cdot W}{13.3K} + \frac{1 \cdot W}{2.45K}} = 20.7K$$



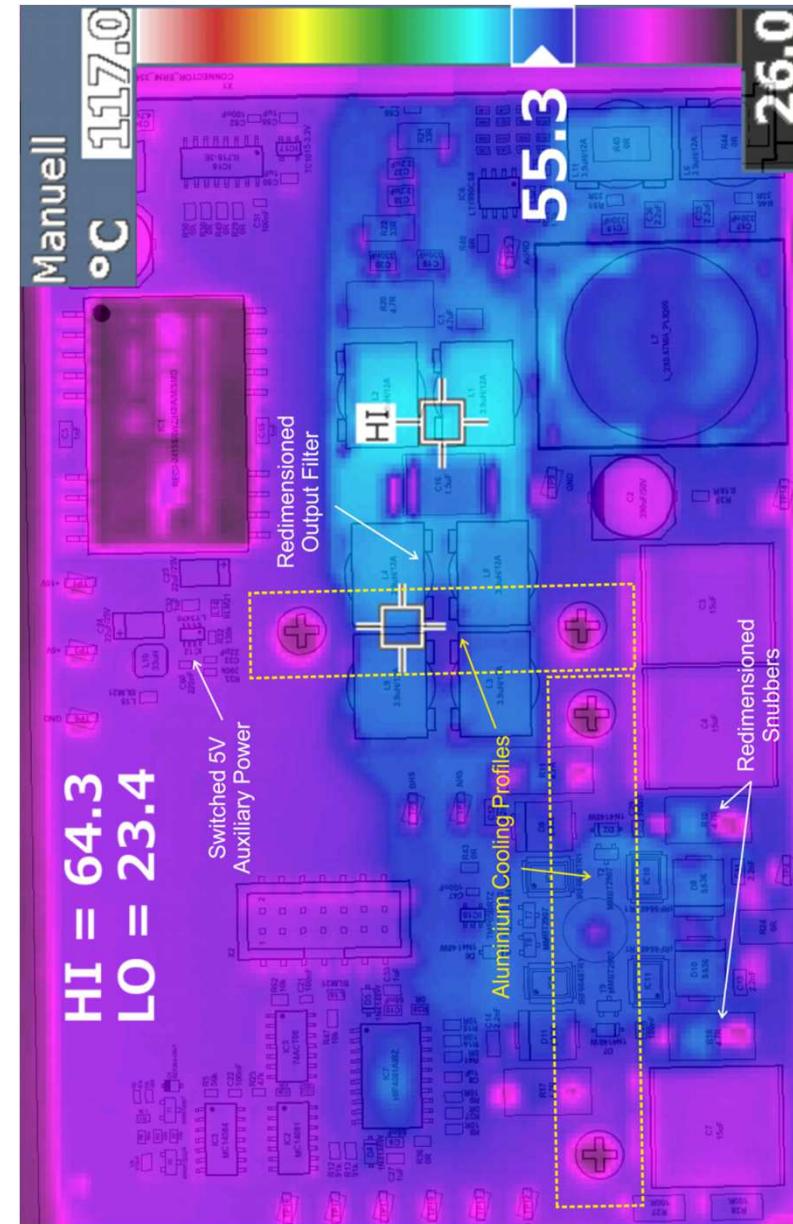
Improve heat flow



Heat transfer to ambient



Comparison Prototype 1 and 2



Better heat spreading

Lower temperatures

Good corre-
lation with
calculations

Thank you for your attention

Questions?



References

- [1] Infineon, Datasheet FF600R06ME3 Rev. 3.1
- [2] Semikron, Applikationshandbuch Leistungs-
halbleiter, VSL Verlag 2010
- [3] Infineon, Thermal equivalent circuit models,
AN2008-03
- [4] Infineon, Technical Information IGBT modules,
Use of Power Cycling curves for IGBT4,
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